

**Measurements of Inclusive
and Diffractive
Electromagnetic Jet
Transverse Single-Spin
Asymmetry in Polarized
p+p Collision at $\sqrt{s} = 200$
GeV at STAR**

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1 Chapter 1

2 Introduction

3 Transverse single-spin asymmetries (A_N), which are defined as left-right asym-
4 metries of the particle production with respect to the plane defined by the
5 momentum and spin directions of the polarized beam, have been observed to be
6 large for charged- and neutral-hadron production in hadron-hadron collisions
7 over a couple of decades [1, 2, 3, 4, 5]. In pQCD, however, the A_N is predicted
8 to be small and close to zero in high energy collisions [6]. There are two major
9 frameworks that can provide a potential explanation for such sizeable asymme-
10 tries. The first one is the transverse-momentum-dependent (TMD) contribu-
11 tions from the initial-state quark and gluon Sivers functions and/or the final-
12 state Collins fragmentation functions. In the Sivers mechanism, the asymmetry
13 comes from the correlation between the proton spin and the parton transverse
14 momentum [7], while the Collins effect arises from the correlation between the
15 spin of the fragmenting quark and the outgoing hadron's transverse momentum
16 [8]. Another framework is based on the twist-3 contributions in the collinear
17 factorization framework, including the quark-gluon or gluon-gluon correlations
18 and fragmentation functions [9].

19 According to the study by CMS Collaboration [11], diffractive interactions
20 contribute to about a significant fraction ($\sim 25\%$) of the total inelastic p+p
21 cross section at high energies. The simulation for hard diffractive events based
22 on PYTHIA-8 predicts that the fraction of diffractive cross section in the total
23 inclusive cross section at the forward region is about 20% [4]. In recent years,
24 analyses of A_N for forward π^0 and electromagnetic jets (EM-jets) in $p^\uparrow + p$
25 collisions at STAR indicated that there might be non-trivial contributions to
26 the large A_N from diffractive processes [5, 10]. Measuring the A_N of diffractive
27 process will provide an opportunity to study the properties and understand the
28 diffractive exchange in p+p collisions.

29 The analyses consist of two parts: inclusive EM-jet A_N at run 15 FMS

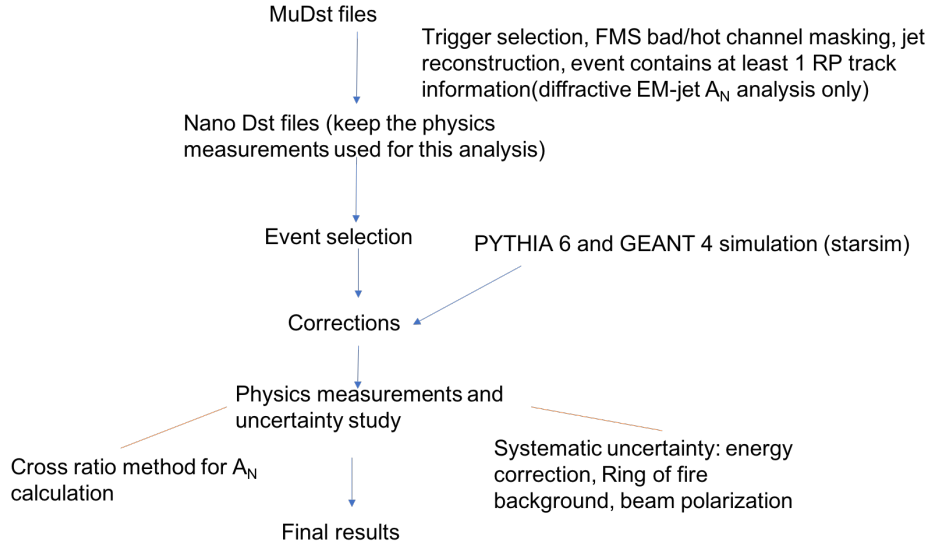


Figure 1.1: General analysis procedures for inclusive and diffractive EM-jet A_N analyses

30 and diffractive EM-jet A_N at run 15 FMS. Compared to the previously STAR
 31 published paper [5], the former analysis on focuses on inclusive EM-jet A_N for
 32 the dependence on photon multiplicity inside the EM-jet, EM-jet transverse
 33 momentum (p_T) and energy. The later analysis is the first measurement for
 34 diffractive EM-jet A_N at STAR.

35 The structure of the analysis note follows the analysis procedures in Fig.(1.1).
 36 Chapter 2 will present the dataset and the data quality assurance (QA). Chap-
 37 ter 3 will present the event selection. Chapter 4 will present the corrections.
 38 Chapter 5 will present the systematic uncertainty. Chapter 6 will present the
 39 final results.

40 Chapter 2

41 Dataset and Quality 42 Assurance (QA)

43 2.1 General information for the dataset

44 The inclusive and diffractive EM-jet A_N analyses both utilize polarized p+p
45 collision at $\sqrt{s} = 200$ GeV taken in run 15. Details of the data set are listed as
46 follow:

- 47 • Trigger setup name: production_pp200trans_2015
- 48 • Data stream: fms
- 49 • Production tag: P15ik
- 50 • File type: MuDst files in Distributed Disk (DD)

51 The run list for the analyses is in Appendix (A).

52 Both analyses generate smaller size data stream files (DST) from the MuDst
53 files, applying trigger filter (described in Sec. (2.2)) and jet reconstruction
54 (described in Sec. 2.4). In addition, the events with at least one Roman Pot
55 track are required for diffractive EM-jet A_N analysis when generating the DST
56 files.

57 2.2 Triggers

58 9 triggers for FMS are used for both analyses. The triggers with their ID are
59 listed in Table (2.1). However, the FMS-sm-bs2 trigger is considered as a source
60 of background and excluded from the trigger list in the final results. Details can
61 be seen in 5.2.1.

Table 2.1: Trigger name lists and trigger ID for run 15

Trigger name	Trigger ID
FMS-JP0	480810 / 480830
FMS-JP1	480809 / 480829
FMS-JP2	480808 / 480828
FMS-sm-bs0	480801 / 480821 / 480841
FMS-sm-bs1	480802 / 480822
FMS-sm-bs2	480803 / 480823 / 480843
FMS-lg-bs0	480804 / 480824 / 480844
FMS-lg-bs1	480805 / 480825
FMS-lg-bs2	480806 / 480826

62 The run-by-run QA for trigger distribution is checked. Figure (xxx) shows
63 the XXX trigger distribution for all the runs for inclusive processes as example.
64 The other trigger distributions are shown in Appendix (B).

65 2.3 Calibration

66 The calibration for run 15 FMS dataset are from STAR framework [14], but
67 with some additional steps. They mainly include the following items:

- 68 • Bit shift (BS): It refers to the binary bit, used to store the ADC value,
69 not starting from the normal lowest bit. The BS will affect a cell's ADC
70 distribution and the corresponding hit energy. The approach to check the
71 BS is to use the ADC of each FMS hit to check with its corresponding BS
72 value of the cell [15].
- 73 • Gain and gain correction: The energy of the hit = $\text{ADC} \times \text{gain} \times \text{gain}$
74 correction. The gain is the calculated value based on a cell's η position,
75 while the gain correction is obtained from offline calibration [14]. The flag
76 of the gain and the gain correction for each tower in the STAR database
77 is "fmsGainCorr-BNL-C".
- 78 • Hot channel and bad channel masking: A hot channel refers to the tower
79 with a number of hits far more than the average number of hits for the
80 whole detector towers within some time range. A bad channel refers to the

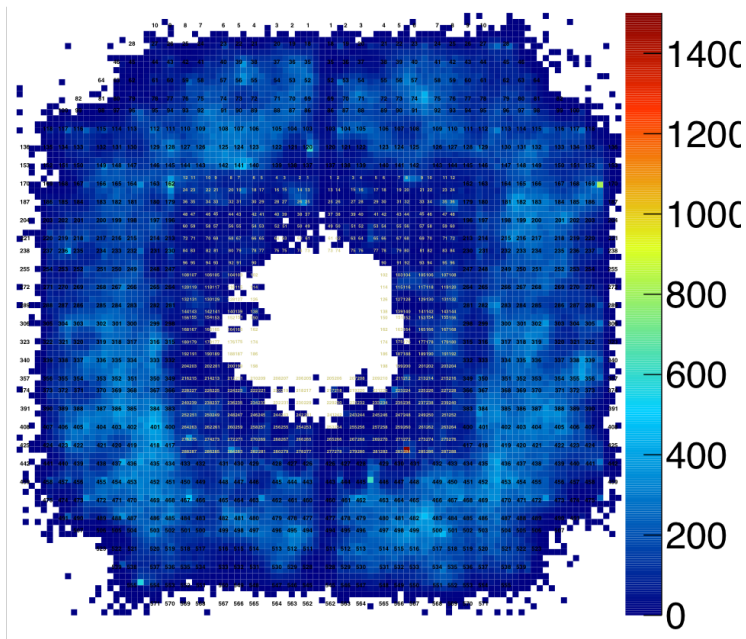


Figure 2.1: Example of EM-jet distribution at FMS before additional hot channel masking. The red color area in this plot indicates the possible hot channels.

81 problematic towers which might be suffered from hardware issues. Both
 82 hot channels and bad channels can affect the quality of the calibration
 83 and the analyses since there are quite a lot of not physical signals con-
 84 taminated. To mask out these channels, the gain values are set to zero.
 85 In addition to the existing hot channel and bad channel masking from
 86 STAR calibration [14], the fill-by-fill hot channel masking is applied in
 87 both analyses. The EM-jet distribution before any event selections for
 88 every fill is checked to find out any possible hot channels. The EM-jet
 89 reconstruction is discussed in 2.4. Figure (2.1) shows one example of the
 90 EM-jet distribution at the FMS. The areas with extremely high EM-jet
 91 entries compared to the overall average entries in the plot are assumed to
 92 be the hot channel area. The channels within these areas are considered
 93 hot channels and added manually to the hot channel lists. Figure (2.2)
 94 shows the EM-jet distribution for fill 18827 as an example after the ad-
 95 ditional hot channel masking. From the plot, the hot channels disappear
 96 and the entries of the majority of towers are close to the average entries.

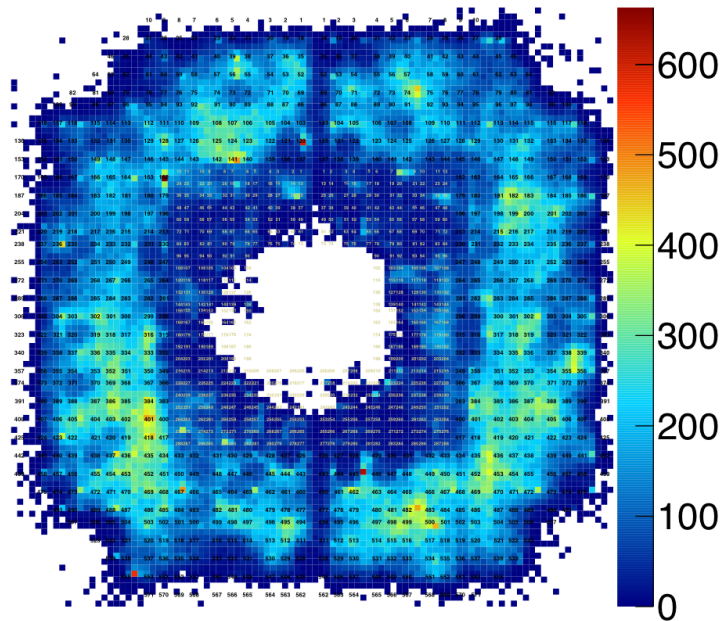


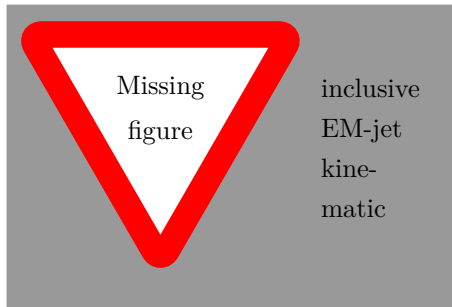
Figure 2.2: Example of EM-jet distribution at FMS after additional hot channel masking.

97 2.4 Electromagnetic jet reconstruction

98 The Electromagnetic jets (EM-jets) are the jet consisting of only photon. The
 99 photon candidates for EM-jets reconstruction are the FMS points. The FMS
 100 points are formed by the shower shape fitting for the FMS clusters, where the
 101 FMS clusters are the groups of adjacent FMS hits by FMS cluster finding al-
 102 gorithm. The hits are the basic reconstructed object in the FMS, which are
 103 formed by the towers with non-zero ADC value [12].

104 In order to reduce the noise background, the FMS points with $E > 2GeV$
 105 and $E_T > 0.2GeV$ are considered in the analysis. The EM-jets are reconstructed
 106 with the anti- k_T algorithm from the FastJet package [13], with the resolution
 107 parameter $R = 0.7$. The primary vertex of the EM-jets are determined according
 108 to the priority of TPC vertex, BBC vertex and VPD vertex. If the primary
 109 vertex is unable to determined among these three detectors, it will set to be
 110 $(0,0,0)$.

111 Figure (xxx) shows the EM-jet kinematic for the inclusive process.



113 Chapter 3

114 Event Selection

115 The event selections for inclusive and diffractive EM-jets include the following
116 items:

- 117 1. Triggers: The triggers used for both analyses are the FMS BS triggers and
118 FMS JP triggers. They are listed in Table(2.1). Only the events with any
119 triggers fired are kept.
- 120 2. EM-jet reconstruction: EM-jets are reconstructed by FMS point by Anti-
121 k_T algorithm with $R = 0.7$. The FMS points are required to have $E > 2$
122 GeV and $E_T > 0.2$ GeV. Details of the EM-jet reconstruction are in Section
123 (2.4)
- 124 3. EM-jet cut: Details of the EM-jet cuts are in Section (3.1)
 - 125 • The EM-jets for inclusive EM-jet analysis are required to have $p_T > 2$
126 GeV, while the EM-jets for diffractive EM-jet analysis are required
127 to have $p_T > 1$ GeV.
 - 128 • The vertex z are within $[-80, 80]$ cm.
 - 129 • The pseudorapidity (η) of the EM-jets are within $[2.8, 3.8]$ for inclu-
130 sive EM-jet analysis and $[2.6, 4.1]$ for diffractive EM-jet analysis.
 - 131 • The event with EM-jet $|x_F| > 1$ or $E > 100$ GeV are excluded.
 - 132 • The number of EM-jets for each event is not zero.
- 133 4. Event property cut: Details of the event property cuts are in Section (3.2)
 - 134 • Veto on abort gap.
 - 135 • The spin status for the blue beam and yellow beam is correct and
136 accept the 4 cases of 4-bit spin patterns.

- 137 5. Roman Pot (RP) track cut: These cuts are only used for diffractive EM-jet
138 analysis. Details are in Section (3.3)
- 139 • Only accept the event with the following 2 cases: no east side RP
140 track and only one west side RP track; only one east side RP track
141 and only one west side RP track.
 - 142 • Each RP track must hit at least 7 RP silicon planes.
 - 143 • Each RP track must satisfy $-2 < \theta_x < 2$ mrad and $1.5 < |\theta_y| < 4.5$
144 mrad.
- 145 6. Background cut: Details of the background cut are in Section (3.4).
- 146 • Ring of fire cut (for both analyses): Exclude FMS-sm-bs3 trigger.
 - 147 • sum energy cut (only for diffractive EM-jet analysis): Cut on the sum
148 of west side RP track energy and EM-jet energy. Details in Table
149 (???)
 - 150 • West BBC ADC sum cut (only for diffractive EM-jet analysis): west
151 side large BBC ADC sum < 80 and west side small BBC ADC sum
152 < 100 .
- 153 7. Corrections: Apply EM-jet energy correction (details in Sector(???) and
154 Underlying-Event (UE) correction (details in Sector(???)

155 3.1 EM-jet cut

156 The EM-jet reconstruction is based on the anti- k_T algorithm by the FastJet
157 package, with the R parameter 0.7, which is described in 2.4. To reduce the
158 background EM-jet, the p_T cut is applied. For the inclusive EM-jet, the cut is
159 $p_T < 2$ GeV. However, the diffractive process applies the cut on EM-jet $p_T < 1$
160 GeV, due to the limited statistics for this process.

161 The EM-jet vertex is determined by the primary vertex following the priority
162 of TPC, BBC ,and VPD. If the primary vertex can be obtained by TPC, the
163 TPC vertex will be the primary vertex. Otherwise, check the BBC vertex on
164 the next step. If there is no BBC vertex, then check the VPD vertex. If there
165 is still no VPD vertex, the primary vertex is set to be $z=0$. The vertex z cut on
166 $|z| < 80$ cm is considered for both inclusive and diffractive processes.

167 In addition, we apply the cut on EM-jet η which aims to get rid of the bad
168 reconstructed EM-jets and the EM-jets hitting outside the FMS. Therefore, the
169 EM-jet cut are [2.8, 3.8] for inclusive EM-jet analysis and [2.6, 4.1] for diffractive
170 EM-jet analysis.

Table 3.1: 4 acceptable 4-bit spin patterns

4-bit spin	Translate	Blue beam polarization	Yellow beam polarization
0101	5	up	up
0110	6	up	down
1001	9	down	up
1010	10	down	down

171 Also, the events with EM-jet energy $E > 100$ GeV or $|x_F| > 1$ are discarded,
 172 where Feynman-x x_F can be estimated by the EM-jet energy divided by the
 173 beam energy ($x_F = \frac{2E}{\sqrt{s}}$). Those events are possibly pile-up events.

174 Finally, the events are required to have non-zero EM-jets. Although those
 175 events with zero EM-jets are not counted in the EM-jet yield when calculating
 176 the A_N , they still have effects in polarization calculation, which have some
 177 effects on the final A_N results. Applying the non-zero EM-jet cuts will solve
 178 this issue and calculate the precise polarization.

179 3.2 Event property cut

180 The abort gap for both blue beam and yellow beam is within bunch ID [31, 39]
 181 and [111, 119] for run 15. Figure (3.1) shows one example of bunch crossing
 182 distribution for one physics run. The bunches with low entries are the abort
 183 gap. The events with either blue beam or yellow beam with the abort gap are
 184 discarded.

185 The spin patterns for each beam, either up or down, are obtained from the
 186 bunch crossing of each event. The translation from the database for the spin
 187 patterns is described in [16]. The spin patterns for both blue and yellow beam
 188 are combined as 4-spin bit. The events satisfying the following 4 4-spin bit
 189 cases in Table (3.1) are considered in both analyses. These patterns require the
 190 polarization of both blue and yellow beam either up or down.

191 3.3 Roman Pot track cut

192 Roman Pot (RP) detector is used for detecting the slightly scattered proton
 193 along the beam. The RP tracks are generally recognized as slightly scattered
 194 protons. To identify the diffractive process, the coincidence between the FMS
 195 detector and RP detector is required, which can satisfy the requirement of the
 196 presence of the rapidity gap for the diffractive process. Therefore, two possible
 197 channels are considered for the diffractive processes, which can be shown in
 198 Figure (3.2). Figure (3.2 top) shows the diffractive channel requiring no east

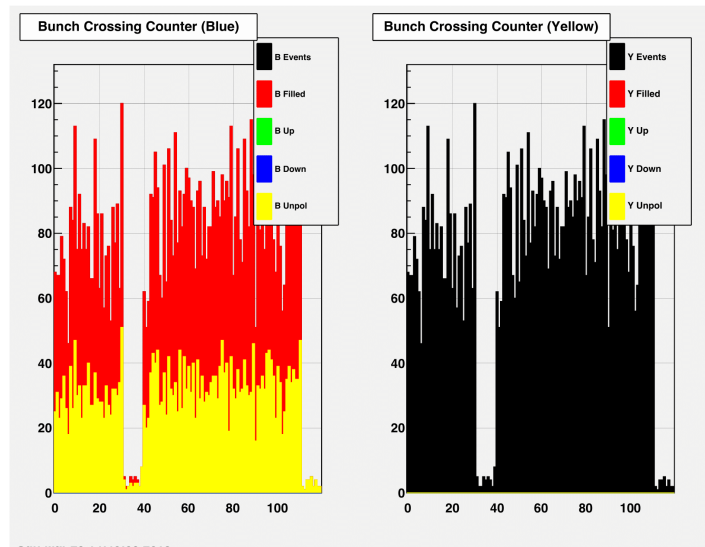


Figure 3.1: Bunch crossing distribution for run 16088023 as example. Left plot shows the blue beam bunch crossing distribution; right plot shows the yellow beam bunch crossing distribution. The abort gap for both blue beam and yellow beam are with bunch ID [31, 39] and [111, 119].

199 side RP track and only one west side RP track, while Figure (3.2 bottom) shows
 200 another channel requiring only one east side RP track and only one west side RP
 201 track. Channels other than the 2 acceptable cases are not considered because
 202 they might contain background noise or pile-up events.

203 The next step is to identify if the RP tracks are good tracks. First of all, the
 204 RP track needs to hit at least 7 silicon planes. According to the RP design, there
 205 are 2 sets of RP (inner and outer) on each side. Each set contains a package
 206 above and below the beamline. Each package contains 4 silicon planes, where
 207 2 of them are used to determine the hit position in x direction and the rest 2
 208 are used to determine the hit position in y position direction. The requirement
 209 of RP track hitting at least 7 silicon planes will make sure not only the RP
 210 track hits both packages, but also the hit position and track momentum can
 211 be reconstructed more precisely. In addition, this cut can reduce the RP tracks
 212 from background noise significantly, since a large number of background tracks
 213 hit less than 4 silicon planes.

214 Then, the cuts on the polar angle of the RP tracks in the x-z plane (θ_x) and
 215 y-z plane (θ_y) are applied to make sure the RP tracks are good reconstructed
 216 tracks. The ranges of the cuts are obtained from the RP track θ_x and θ_y distri-
 217 bution in both simulation and data. The simulation is based on RP, using the
 218 Pythia8 + GEANT4 simulation framework. The details of the RP simulation
 219 and the description of the cuts from the simulation are in Appendix (C). Figure
 220 (3.3) show the only east side RP track θ_x (left plot) and θ_y (right plot) for data
 221 with the cut on the number of silicon planes that RP track hit, and Figure (3.4)
 222 show the only west side RP track θ_x (left plot) and θ_y (right plot) for data with
 223 the cut on the number of silicon planes that RP track hit.

224 3.4 Background cut

225 There are quite a large number of pile-up events in data, which have a serious
 226 impact on measuring the diffractive EM-jet A_N precisely. To deal with this
 227 effect, two additional sets of cuts are applied to minimize the pile-up effect.

228 The first set of cuts is based on the sum of west side RP track energy
 229 and EM-jet energy (sum energy). As shown in Figure (3.2), both possible
 230 channels contain only one west side RP track and EM-jets at FMS. In addition,
 231 the accidental coincident events usually have the sum energy greater than the
 232 proton beam energy, so it's a good idea to consider the cut based on the sum
 233 energy. The cuts on the sum energy are varied by the different x_F regions,
 234 where x_F is the scaling variable of the particle in the hadronic collision and
 235 can be calculated as the EM-jet energy divided by the proton beam energy for
 236 the FMS EM-jets. The cuts are based on the splitting of the two peaks for

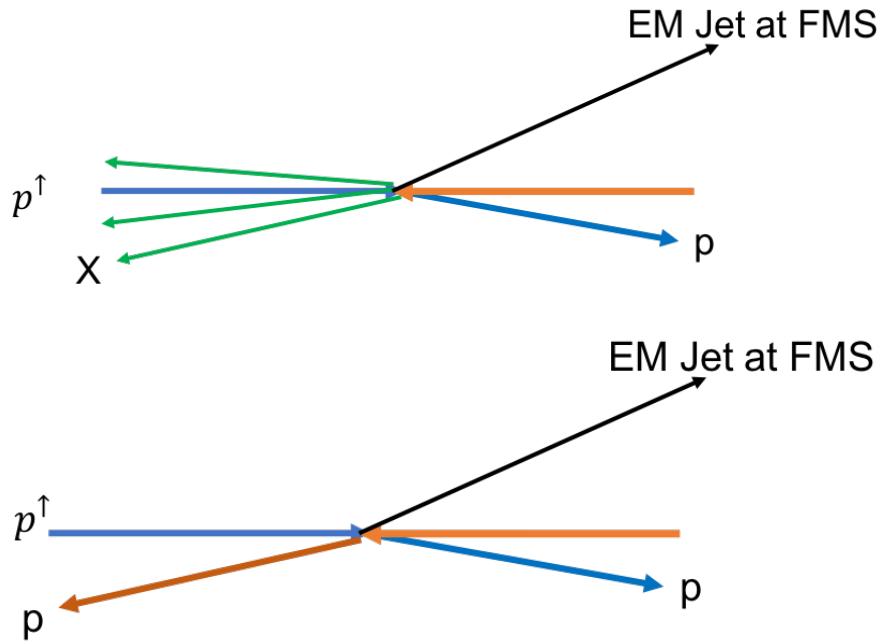


Figure 3.2: 2 possible channels for diffractive processes.

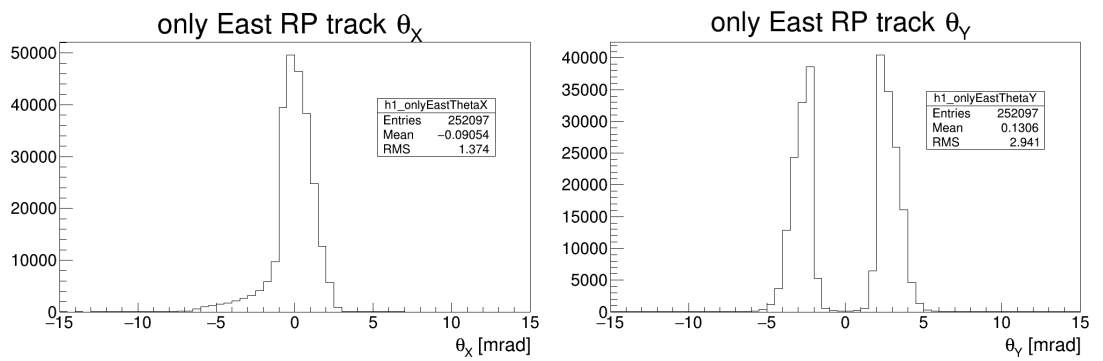


Figure 3.3: Distribution of the east side RP track θ_x (left plot) and θ_y (right plot)

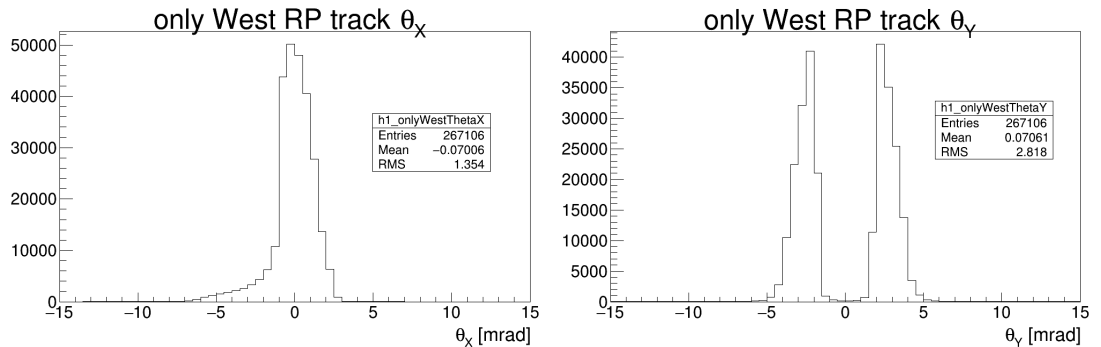


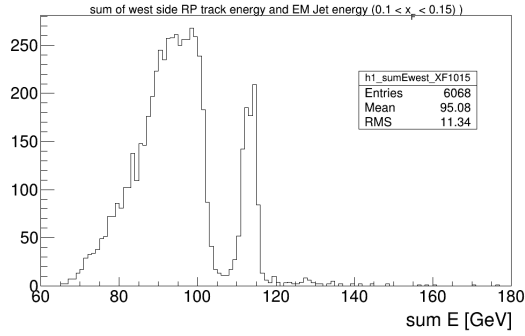
Figure 3.4: Distribution of the west side RP track θ_x (left plot) and θ_y (right plot)

Table 3.2: Sum energy cut for different x_F bins

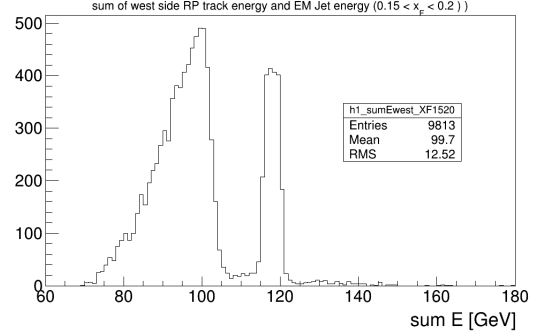
x_F	Sum energy [GeV]
[0.1, 0.15]	<108
[0.15, 0.2]	<108
[0.2, 0.25]	<110
[0.25, 0.3]	<110
[0.3, 0.45]	<115

237 each sum energy distribution (Figure (3.5)), where the peak with the lower sum
 238 energy (close to beam energy, 100 GeV) is considered as the contribution from
 239 the diffractive processes and the peak with the higher sum energy is considered
 240 as the contribution from the pile-up events. Table (3.2) shows the sum energy
 241 cuts for the EM-jets at each x_F region.

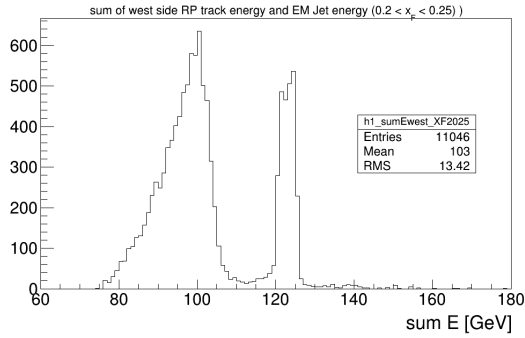
242 The second cuts are based on the Beam-Beam Counter (BBC), which is
 243 used for triggering, luminosity monitoring and local polarization measurement
 244 [?]. Generally, the pile-up events are more likely to appear in the high luminosity
 245 collision. In addition, the higher luminosity detected in an event, the higher the
 246 BBC ADC sum value will be collected. To decide the threshold of the BBC ADC
 247 sum value from the event, the combination with sum energy cut is considered
 248 to determine these cuts from BBC. In this analysis, only the west side BBC
 249 detector responses are considered. Based on the BBC design, the BBC ADC
 250 sum values from 2 different regions (small BBC and large BBC) are considered.
 251 Figure (3.6) show the 2-dimension distribution of sum energy and west side
 252 small (large) BBC ADC sum. To simplify, the events with sum energy less
 253 than 108 GeV are considered signals while the events with sum energy greater
 254 than 108 GeV are considered backgrounds. Also, to better qualify the cuts, the
 255 ratios of signals to backgrounds by every BBC ADC sum bin are calculated and



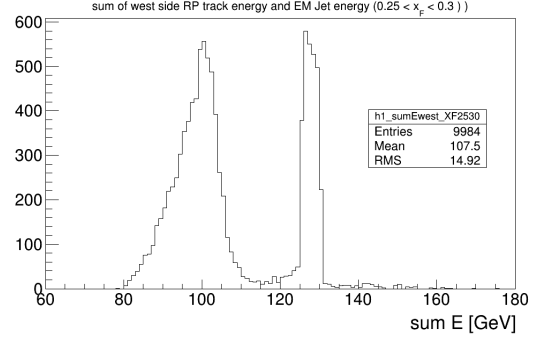
(a) Sum energy distribution for EM-jet with $0.1 < x_F < 0.15$.



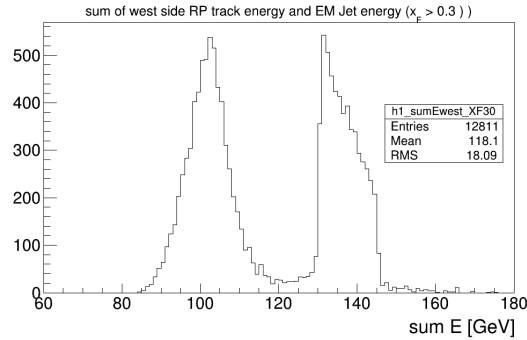
(b) Sum energy distribution for EM-jet with $0.15 < x_F < 0.2$.



(c) Sum energy distribution for EM-jet with $0.2 < x_F < 0.25$.



(d) Sum energy distribution for EM-jet with $0.25 < x_F < 0.3$.



(e) Sum energy distribution for EM-jet with $0.3 < x_F < 0.45$.

Figure 3.5: Sum energy distribution for EM-jet with $0.1 < x_F < 0.45$, but separate by 5 different x_F region.

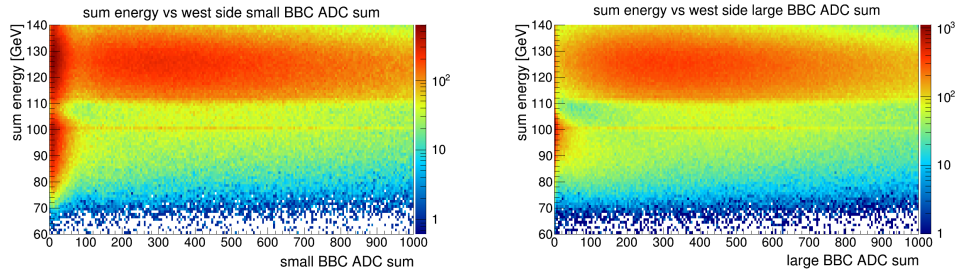


Figure 3.6: Distribution of sum energy vs west side small BBC ADC sum (left plot) and sum energy vs west side large BBC ADC sum (right plot). The region with sum energy > 108 GeV is considered as background and the region with sum energy < 108 GeV is considered as signal.

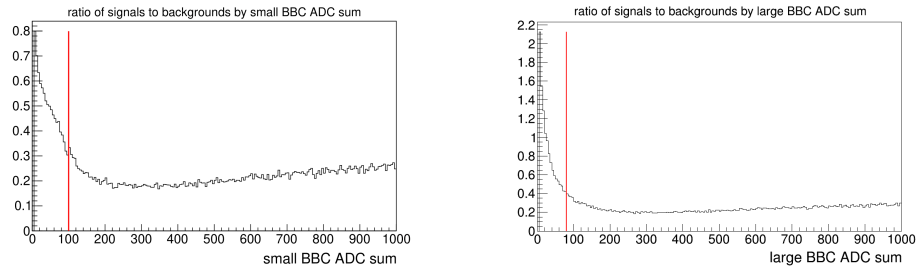


Figure 3.7: Distribution by every small BBC ADC sum bin (left) and by every large BBC ADC sum bin (right). The red vertical line indicate the proper cut for small (large) BBC ADC sum.

256 presented in Figure (3.7). From the figures, the west side small BBC ADC sum
 257 cut is less than 100 and the west side large BBC ADC sum cut is less than 80.

258 Chapter 4

259 Corrections

260 4.1 Underlying Event (UE) correction

261 4.1.1 Underlying Event energy correction for diffractive 262 process

263 The underlying event is a part of a jet, not from the parton fragmentation but
264 from secondary scattering or other processes. This will deposit some energy to
265 the jet, so the correction on UE is required to subtract its energy (momentum)
266 from the jet. The commonly used method is the "cross-ratio" method [19].
267 In this method, first of all, two off axis jets with same pseudorapidity but at
268 $\pm 1/2\pi$ azimuthal angle at the edge of the original jet are reconstructed as UE
269 background. Then, the UE energy density can be calculated using $\rho = E/(\pi R^2)$,
270 where E is the UE energy and R is the UE jet radius. The fastjet program use
271 the "ghost particle" technique to calculate the UE energy density (ρ) and jet area
272 (A). The maximum "ghost particle" η is 5.0 and the "ghost area" is 0.04. Finally,
273 the jet energy will be subtracted by the UE energy: $E_{corrected} = E_{original} - \rho \times A$,
274 where the corrected EM-jet energy is $E_{corrected}$ and the original EM-jet energy
275 is $E_{original}$.

276 Figure (4.1) show the UE correction distribution for EM-jet energy. The left
277 plot shows the subtraction term for the UE correction for EM-jet energy. The
278 right plot shows the EM-jet energy distribution after the UE correction. If the
279 EM-jet energy after subtraction is less than 0 GeV, the energy will be set to 0
280 GeV.

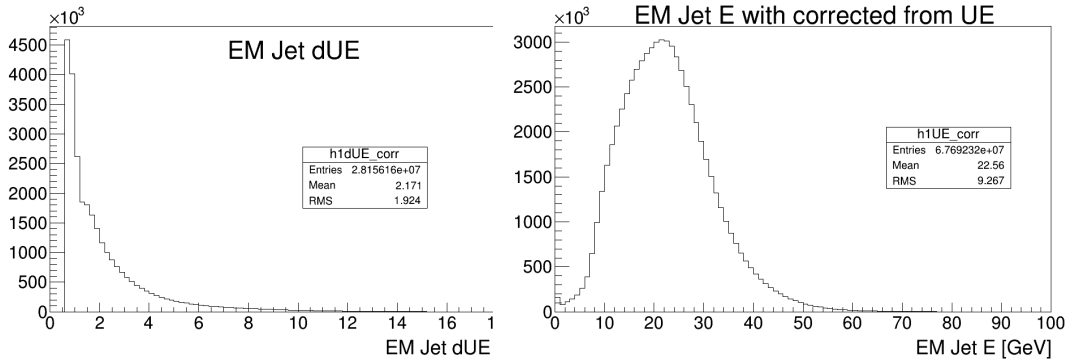
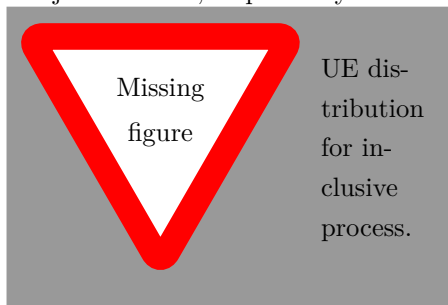


Figure 4.1: UE distribution for diffractive EM-jet analysis. The left plot shows the subtraction term $\rho \times A$. The right plot shows the EM-jet energy distribution after the UE correction.

281 4.1.2 Underlying Event energy correction for inclusive pro- 282 cess

283 The UE correction for the inclusive process is similar to that for the diffractive
284 process, but the correction object is the EM-jet transverse momentum instead
285 of energy. The UE correction method, setup and procedures are the same as
286 explained in Sec. (4.1.1). Since the correction object is the p_T , the calculation
287 formula for EM-jet with UE correction is $p_{T,corrected} = p_{T,original} - \rho \times A$, where
288 the corrected EM-jet p_T is $p_{T,corrected}$, the original EM-jet p_T is $p_{T,original}$,
289 UE p_T density is ρ and jet area is A , respectively.



290

291 4.2 Detector level to particle level EM-jet en- 292 ergy correction

293 The EM-jet energy obtained from FMS is considered detector level EM-jet en-
294 ergy. Therefore, a correction for detector level to particle level EM-jet energy is
295 necessary for both analyses. The correction is based on the Monte Carlo simulation
296 for FMS. The details of the simulation are shown in (D). In the simulation,

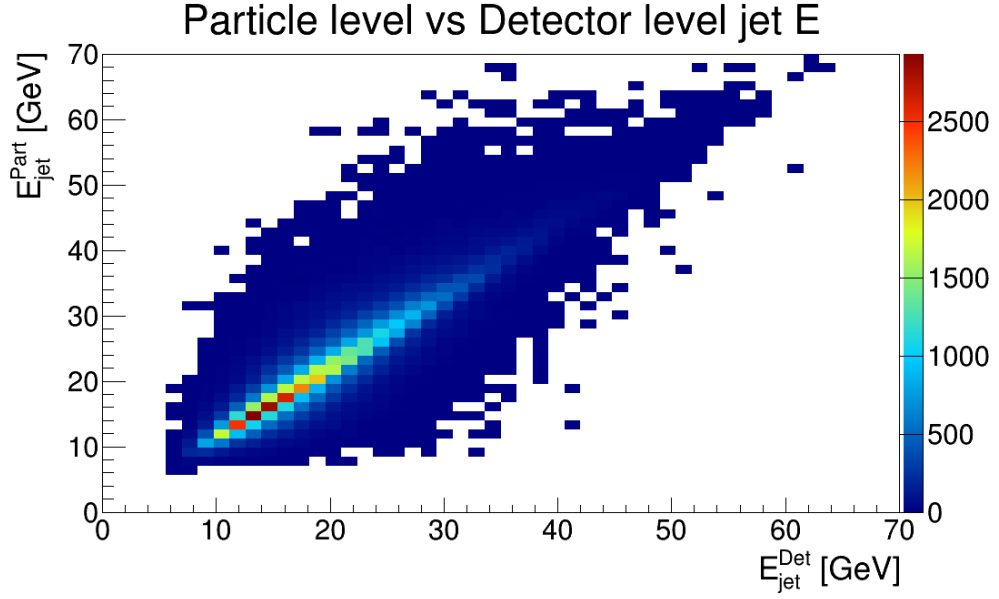


Figure 4.2: EM-jet energy distribution in particle level (y axis) and detector level (x axis) from the FMS simulation.

297 the EM-jets with both particle level and detector level are recorded. Figure (4.2)
 298 shows the EM-jet energy distribution in particle level (y axis) and detector level
 299 (x axis). Figure (4.3) shows the profile of the EM-jet energy distribution with
 300 particle level and detector level. The black points are the correlation between
 301 the EM-jet energy in particle level and detector level. The red curves are the
 302 fit for the points in two different detector level regions: $5 < E < 10$ GeV and
 303 $10 < E < 60$ GeV. The 6th-order polynomial function is used for fitting the
 304 former region and the linear function is used for fitting the latter region. These
 305 functions are used to calculate the corrected energy from the original detec-
 306 tor level energy. The corrected EM-jet energy will finally applied for the x_F
 307 calculation and A_N extraction.

Particle level vs Detector level jet E

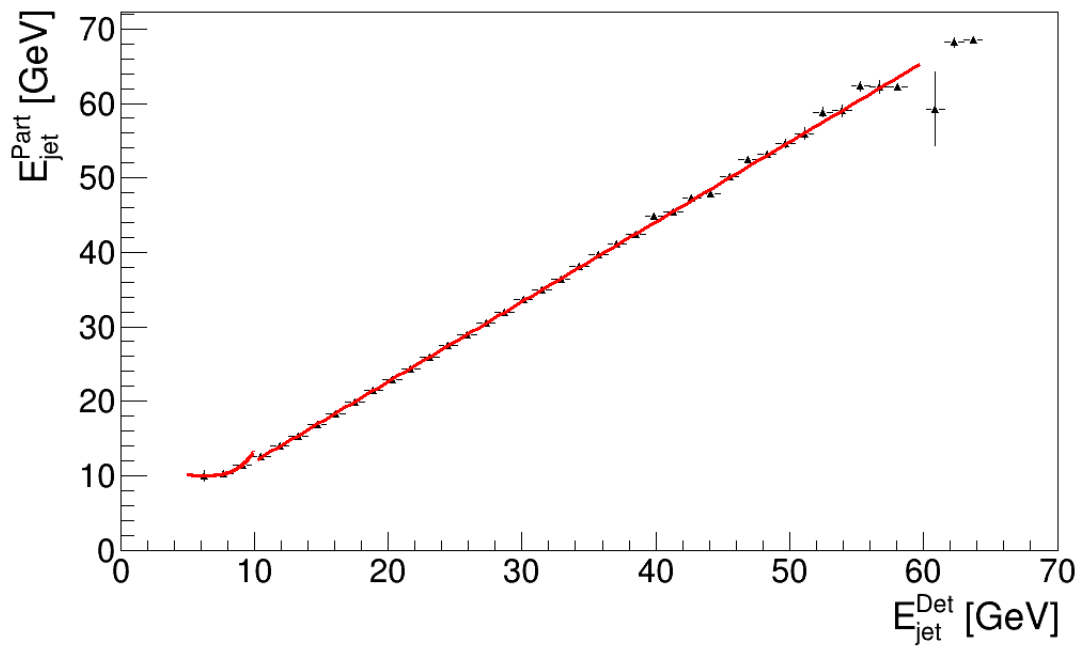


Figure 4.3: The profile of the EM-jet energy distribution with particle level and detector level. The black points are the correlation between the EM-jet energy in particle level and detector level. The red curves are the fit for the black points.

308 Chapter 5

309 Systematic Uncertainty

310 5.1 Energy Uncertainty

311 The systematic uncertainties of EM-jet energy consist of three parts: calibration
312 uncertainty, radiation damage uncertainty, and energy resolution and correction
313 uncertainty.

314 5.1.1 Calibration uncertainty

315 The calibration of FMS towers is done by π^0 reconstruction, which is from
316 two photons reconstruction. The gain correction of each tower is calculated and
317 corrected based on the extraction of the invariant mass peak of the two photons.
318 In this way, the gain correction for all the towers can be correlated. However,
319 the invariant mass peak extraction is biased, based on the fit functions for the
320 signal peak and the background. Therefore, the biased invariant mass peak will
321 raise the uncertainty for the gain correction calculated, which can finally affect
322 the accuracy of the energy of the towers.

323 To estimate such uncertainty, the invariant mass mean difference extracted
324 from two different cases of fitting for the 2-photon invariant mass distribution
325 can be assigned as the energy uncertainty. This uncertainty is estimated to be
326 about 2.5% [12].

327 5.1.2 Radiation Damage Uncertainty

328 The radiation damage is already a common issue for the FMS detector. This
329 damage will introduce systematic uncertainty for the energy in FMS. For the
330 FMS, there is a LED system which can monitor and qualify the radiation damage
331 by observing the long-term gain change for the FMS towers. This gain change

x_F	Energy uncertainty
0.125	8.78%
0.175	3.24%
0.225	3.79%
0.275	4.09%
0.325	4.74%

Table 5.1: Energy correction systematic uncertainty for diffractive EM-jet analysis, separating by each x_F region.

332 information can be used to estimate the contribution of systematic uncertainty
333 by the radiation damage [12].

334 A study had been done to parameterize the radiation damage for run 15
335 FMS [21]. This study shows the systematic uncertainty for run 15 FMS due to
336 the radiation damage is less than 0.5%.

337 5.1.3 Energy Correction Uncertainty

338 Detector level EM-jet energy to particle level EM-jet energy correction has been
339 done. Since this correction is calculated by the polynomial functions, we assign
340 the systematic uncertainty by changing the polynomial functions to express
341 this correction. For the EM-jet energy ranging [5, 10] GeV, the 5-th order
342 polynomial function is applied to calculate the energy correction for systematic
343 uncertainty study. Similarly, the 2-nd order polynomial function is applied for
344 EM-jet energy ranging [10, 60] GeV. Then the energy resolution is calculated
345 using Equation (5.1), where the $E_{systematic}$ is the energy correction calculated
346 using the function for systematic uncertainty study, and the $E_{original}$ is the
347 energy correction calculated using the function explained in Sec. (4.2). The
348 maximum energy resolution for each x_F region is regarded as the systematic
349 uncertainty for the energy correction.

$$energy\ resolution = \frac{|E_{systematic} - E_{original}|}{E_{original}} \quad (5.1)$$

350 For the diffractive EM-jet analysis, the energy systematic uncertainty is
351 listed in Table (5.1), which includes the calibration uncertainty, radiation dam-
352 age uncertainty, and energy correction uncertainty.

x_F	E_{sum} cut original	E_{sum} cut for systematic uncertainty
0.1 - 0.15	$E_{sum} < 108$ GeV	$E_{sum} < 112$ GeV
0.15 - 0.2	$E_{sum} < 108$ GeV	$E_{sum} < 112$ GeV
0.2 - 0.25	$E_{sum} < 110$ GeV	$E_{sum} < 114$ GeV
0.25 - 0.3	$E_{sum} < 110$ GeV	$E_{sum} < 114$ GeV
0.3 - 0.45	$E_{sum} < 115$ GeV	$E_{sum} < 120$ GeV

Table 5.2: Sum energy cut for original study and systematic uncertainty study.

353 5.2 Background uncertainty

354 The background uncertainty contributes to the systematic uncertainty of the
355 final results of A_N . For the inclusive EM-jet analysis, the background uncer-
356 tainty includes the uncertainties on pile-up, abort gap, Ring of Fire, Underlying
357 events, and Unfolding. For the diffractive EM-jet analysis, the background un-
358 certainty includes the uncertainties on Ring of Fire, sum energy cuts, and BBC
359 cuts.

360 5.2.1 Ring of Fire uncertainty

361 The Ring of Fire uncertainty is applied for both analyses. This background
362 is related to the FMS-sm-bs3 trigger. This trigger is targeted at the inner
363 region of FMS which is close to the beam. It's generally recognized that the
364 beam remnants are accepted by FMS-sm-bs3 trigger. Therefore, this trigger is
365 filtered out in both analyses and considered as a source of background. The A_N
366 result difference between considering this trigger and excluding this trigger will
367 be the systematic uncertainty for this background.

368 5.2.2 Sum energy cut uncertainty

369 The sum energy cut uncertainty is applied only for diffractive EM-jet analysis.
370 Details of the sum energy cut are in Sec. (3.4). The sum energy cuts are
371 slightly changed, and the A_N result difference before and after such changes are
372 calculated as the sum energy cut uncertainty. The changes of sum energy cut
373 for systematic uncertainty study are listed in Table (5.2).

374 5.2.3 BBC cut uncertainty

375 The BBC cut uncertainty is only applied for diffractive EM-jet analysis. The
376 details of the BBC cuts are shown in Sec. (3.4). There are slightly changes for
377 the cuts on west side large (small) BBC ADC sum in order to study for the
378 systematic uncertainty. For the large BBC ADC sum cut, the cut change from

$ x_F $	Ring of Fire	E_{sum}	Small BBC	Large BBC	Summary
0.125	4%	30%	21%	26%	45%
0.175	22%	10%	7%	12%	28%
0.225	16%	4%	14%	7%	23%
0.275	22%	6%	1%	10%	25%
0.325	4%	0%	1%	5%	6%

Table 5.3: Background systematic uncertainty for diffractive EM-jet A_N result of blue beam ($x_F > 0$)

$ x_F $	Ring of Fire	E_{sum}	Small BBC	Large BBC	Summary
0.125	15%	59%	4%	46%	77%
0.175	4%	7%	10%	16%	21%
0.225	2%	14%	11%	28%	34%
0.275	9%	53%	6%	76%	93%
0.325	17%	7%	5%	5%	20%

Table 5.4: Background systematic uncertainty for diffractive EM-jet A_N result of yellow beam ($x_F < 0$)

379 60 to 65. For the small BBC ADC sum cut, the cut change from 100 to 105.
380 The two changes are applied separately to study the systematic uncertainty by
381 calculating the difference for the A_N results with and without the changes.

382 5.2.4 Summary for the background uncertainty

383 Table (5.3) (Table (5.4)) shows the background uncertainty for each individual
384 term and the summary term for blue (yellow) beam A_N for diffractive EM-jet
385 A_N results. The summary term use the sum of the square for each individual
386 term: $\sigma = \sum_i \sigma_i^2$.

387 5.3 Polarization uncertainty

388 The blue beam and yellow beam polarization is used to calculate the A_N re-
389 sults. As a habit, the uncertainty of beam polarization uncertainty is listed
390 independently. The beam polarization measurement results are provided by the
391 CNI group, which develops, maintains and operates the RHIC polarimeter mea-
392 surement. The beam polarization measurement results are listed in the table
393 in webpage [22]. In the webpage, the starting time (t_0), the polarization of the
394 blue (yellow) beam at the beginning of every fill (P_0), the decay rate ($\frac{dP}{dt}$) are
395 provided for each fill. For each event, the beam polarization can be calculated
396 from the time difference from the beginning of the fill using Equ. (5.2), where

397 t_{event} is the time of each event. The beam polarization for each run can be
398 calculated by Equ. (5.3), where t_{run} is the time of the center of the run. The
399 beam polarization for each fill can be calculated with the weighted average run
400 polarization with Equ. (5.4), where L_{run} is the luminosity of each run. How-
401 ever, since L_{run} is proportional to the number of events in each run, the number
402 of events in each run can replace the luminosity of each run in the calculation.

$$P_{event} = P_0 + \frac{dP}{dt}(t_{event} - t_0) \quad (5.2)$$

$$P_{run} = P_0 + \frac{dP}{dt}(t_{run} - t_0) \quad (5.3)$$

$$P_{fill} = \frac{\sum_{run} L_{run} P_{run}}{\sum_{run} L_{run}} \quad (5.4)$$

403 The uncertainty of beam polarization includes three parts: the scale uncer-
404 tainty, fill-to-fill uncertainty, and uncertainty from the profile correction proce-
405 dure [23].

406 The scale uncertainty is related to the polarization measurement methods.
407 It includes H-jet scale, H-jet background and pC scale. For run 15, the scale
408 uncertainty is 3% [23].

409 The relative uncertainty of the profiles correction for one beam in one fill
410 is 2.2%. For a set of M fills, the relative profile correction for the single-spin
411 asymmetry measurement is $\sigma(profile)/P = 2.2\%/\sqrt{M}$ [23]. For the run 15
412 FMS dataset used for both analyses, this uncertainty is about 0.3%.

413 The fill-to-fill uncertainty is propagated based on Equ. (5.4) with the uncer-
414 tainty of P_0 and $\frac{dP}{dt}$. The uncertainty for these two terms ($\sigma(P_0)$) and ($\sigma(\frac{dP}{dt})$)
415 for either blue beam or yellow beam can be obtained in [22]. This uncertainty
416 can be expressed in Equ. (5.5). The third term on the right side of the equation
417 is due to the sensitivity of the measurement of the energy scale of the nuclei in
418 the pC polarimetry [12], and it's negligible. However, for the term (Equ. (5.6)),
419 this correction is overcounting for the measurement using a fraction of the run
420 period. Therefore, a correction scale factor $\sqrt{1 - \frac{M}{N}}$ is applied for the second
421 term, which shows in Equ. (5.7). For both analyses, N=54 and M=142. The
422 fill-to-fill uncertainty for diffractive EM-jet analysis is about 0.3%

$$\sigma^2(P_{fill}) = \sigma^2(P_0) + \sigma^2\left(\frac{dP}{dt}\right) \cdot \left(\frac{\sum_{run} t_{run} L_{run}}{L_{fill}} - t_0\right)^2 + \left(\frac{\sigma(fill - to - fill)}{P}\right)^2 \cdot P_{fill}^2 \quad (5.5)$$

$$P_{set}^2 = \left(\frac{\sum_{run} t_{run} L_{run}}{L_{fill}}\right) \quad (5.6)$$

$$P_{fill-to-fill\ scale}^2 = \left(1 - \frac{N}{M}\right) \cdot P_{set}^2 \quad (5.7)$$

423 In summary, the polarization uncertainty is calculated in the quadrature.
424 For the diffractive EM-jet analysis, it's about 3%.

⁴²⁵ **Appendix A**

⁴²⁶ **Run list**

⁴²⁷ **Appendix B**

⁴²⁸ **Trigger distribution**

429 Appendix C

430 Roman Pot simulation

431 In Roman Pot simulation, PYTHIA8 generates the particle level events and
432 GEANT4 is used for the RP detector level simulation.

433 The version of PYTHIA8 used in this analysis is 8.2.35 [17]. This Pythia
434 version allows the simulation on diffractive process, including single diffractive,
435 double diffractive and hard diffraction processes. In this analysis, we use the
436 embedded Pythia in STAR database. The class for the embedded Pythia is
437 "StarPythia8". The proton-proton collisions with $\sqrt{s} = 200$ GeV are simulated.
438 There are totally of 4 million events generated in the simulation. The single
439 diffractive processes are selected to simulate the diffractive processes.

440 After PYTHIA simulation for particle level, GEANT 4 simulation with RP
441 detector is applied in the detector level simulation. This RP simulation frame-
442 work called "pp2pp" was developed by STAR Roman Pot group [18]. In this
443 analysis, the 2015 geometry is used, where DX magnet and DX-D0 chamber are
444 implemented specifically for Run 15. The particle level simulation results from
445 PYTHIA 8 are used as the input for RP simulation.

446 After the simulation on RP, the RP tracks are checked. For the west side
447 RP, figure (C.1) shows the number of silicon planes that the west side RP track
448 hits; and figure (C.2) shows the number of silicon planes that the east side RP
449 track hits. From the plot, if we choose to consider the global tracks which are
450 the tracks hitting 2 RP packages, we should consider the tracks which hit more
451 than 4 planes. Also, the tracks hitting 8 planes are dominant. For the data,
452 therefore, the tracks hitting more than 6 planes will be considered to allow more
453 reasonable statistics.

454 After that, the cut on RP tracks hitting more than 6 planes is applied when
455 analyzing the simulation data. Figure (C.3) show the only east side RP track
456 θ_x (left plot) and θ_y (right plot), and Figure (C.4) show the only west side RP
457 track θ_x (left plot) and θ_y (right plot). The distributions of either θ_x and θ_y are

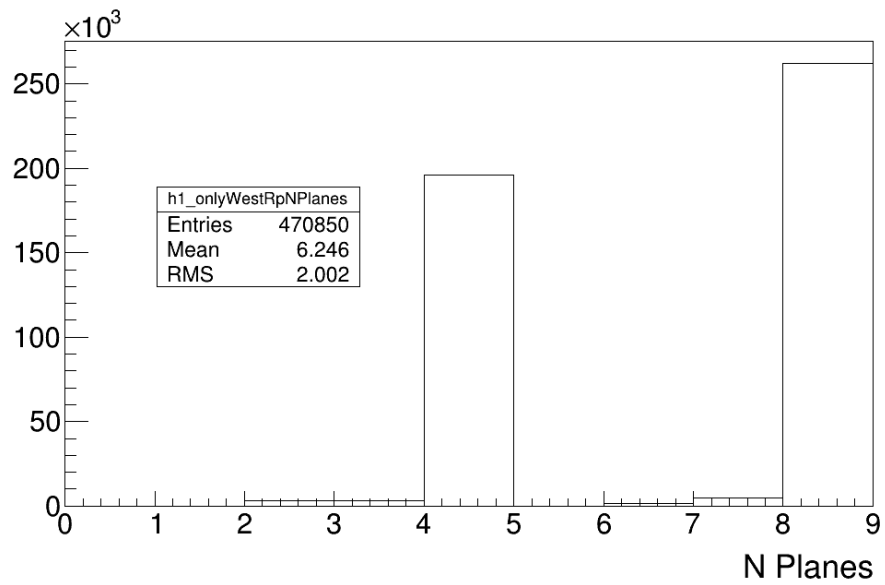


Figure C.1: Number of silicon planes that the west side RP track hits.

458 similar between the east side and the west side RP tracks. Therefore, the same
 459 cuts based on θ_x and θ_y can be considered for both the east side and the west
 460 side RP tracks: $-2 < \theta_x < 2$ mrad and $1.5 < |\theta_y| < 4.5$ mrad.

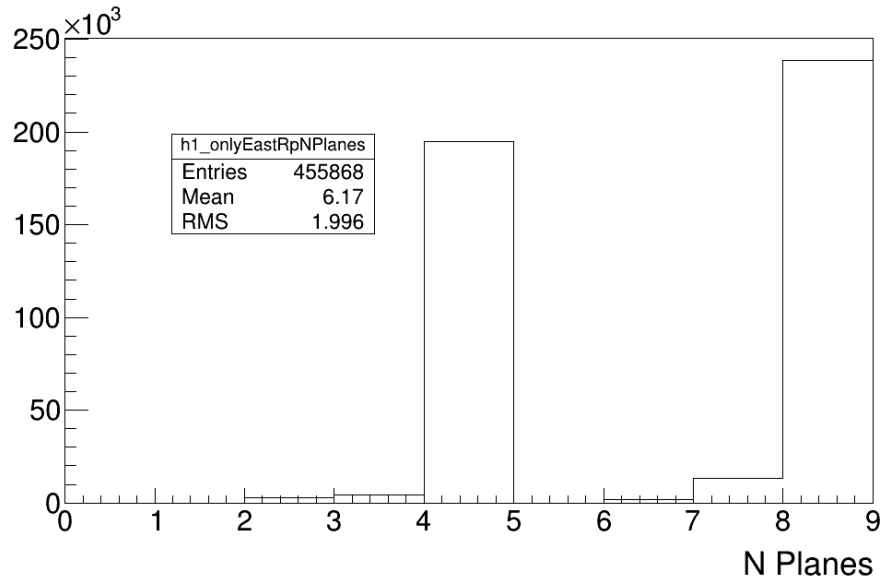


Figure C.2: Number of silicon planes that the east side RP track hits.

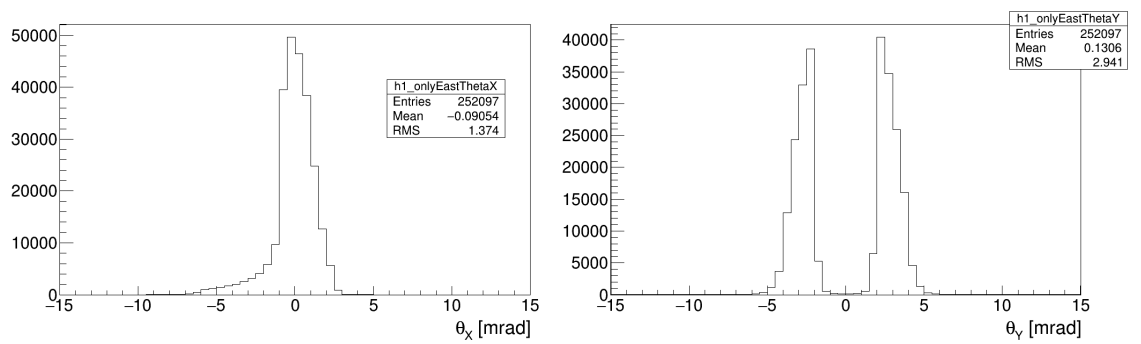


Figure C.3: Distribution of the only east side RP track θ_x (left plot) and θ_y (right plot)

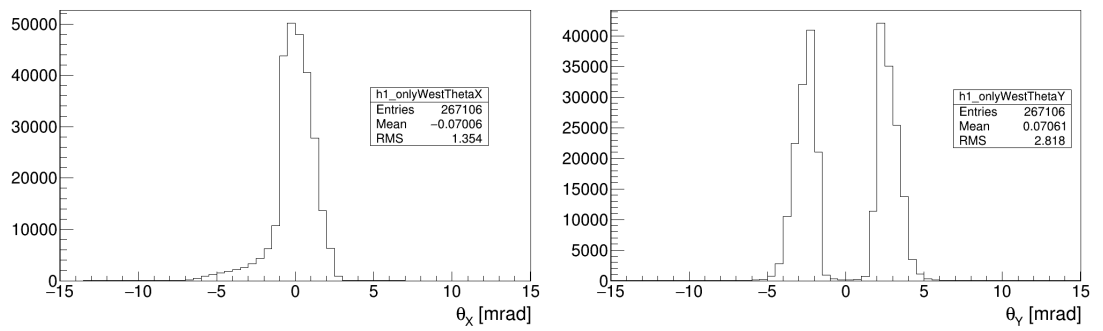


Figure C.4: Distribution of the only west side RP track θ_x (left plot) and θ_y (right plot)

461 Appendix D

462 FMS simulation

463 PYTHIA6 generates the particle level events in the simulation, and GEANT3
464 is used for the FMS detector level simulation.

465 For the PYTHIA simulation, the proton-proton collisions with $\sqrt{s} = 200$
466 GeV are generated, with the tune setting of Perugia6 (Tune parameter 370)
467 [20]. Then, the GEANT3 with FMS detector response implemented under
468 STAR simulation framework ("starsim") are used for the FMS simulation. The
469 Big Full Chain (BFC) proceeds for the event reconstruction. The chain option
470 is "ry2015a agml usexgeom MakeEvent McEvent vfmce Idst BAAna l0 l3 Tree
471 logger fmsSim fmspoint evout -dstout IdTruth bigbig fzin geantout clearmem
472 sdt20150417.193427". The EM-jet reconstruction is proceeded along with the
473 BFC process. The Anti- k_T algorithm with $R=0.7$ is used for the EM-jet re-
474 construction, the same as the EM-jet reconstruction for data. Details of the
475 EM-jet reconstruction are shown in 2.4. In addition, the event filter (StFmsFil-
476 terMaker) and the trigger simulator (StFmsTriggerMaker) are applied during
477 the BFC process. The former filter is based on the energy sum per FMS quad-
478 rant, while the latter filter is based on the FMS trigger. Finally, those events
479 passing the filter in the event level and the trigger are saved for both particle
480 level and detector level.

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